

# Optimisation of copper electroforming for manufacturing superconducting radiofrequency cavity substrates



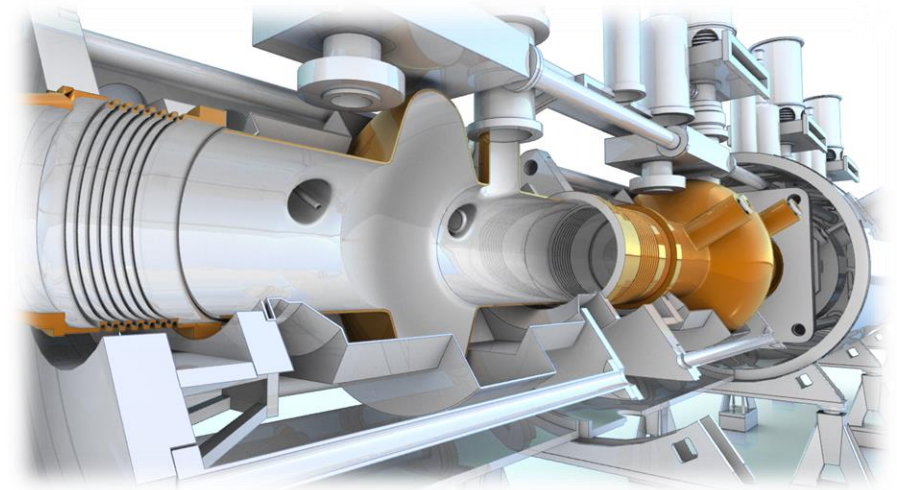
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# Introduction

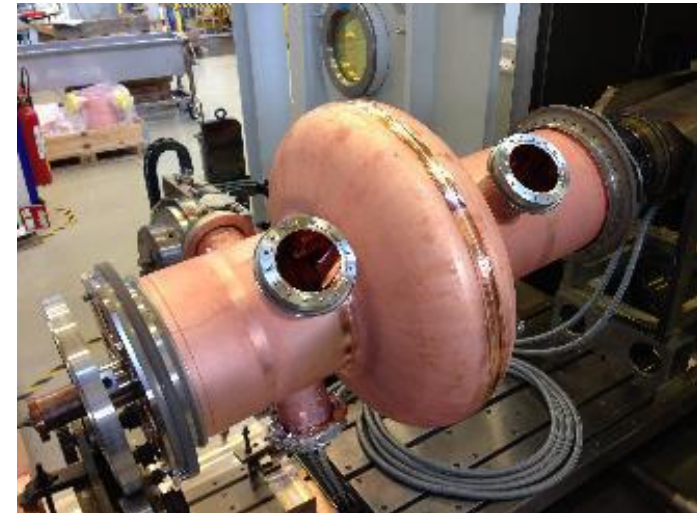
## Future Circular Collider (FCC) study

- Develops designs for the next generation particle collider after LHC.
- SRF cavities will be produced by applying niobium superconducting thin films onto copper substrate cavities.



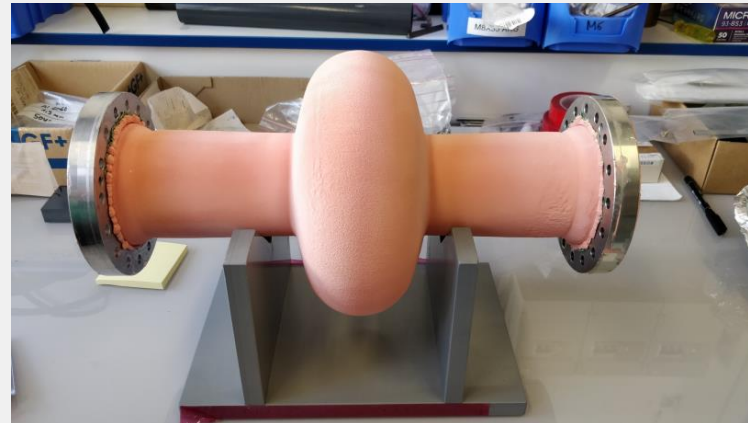
## Copper elliptical cavities

- Copper substrates are traditionally produced by mechanical forming and welding several subcomponents.



# Introduction

- The presence of the weld groove in the most critical place of the cavity for RF performance (equator) has been problematic.
  - A seamless process, which guarantees a high quality Cu substrate and very smooth surface finishing, is pursued.
- In the present innovative approach, seamless cavities are produced by **copper electroforming** on a sacrificial aluminium mandrel which has the internal shape of the cavity.



# Motivation

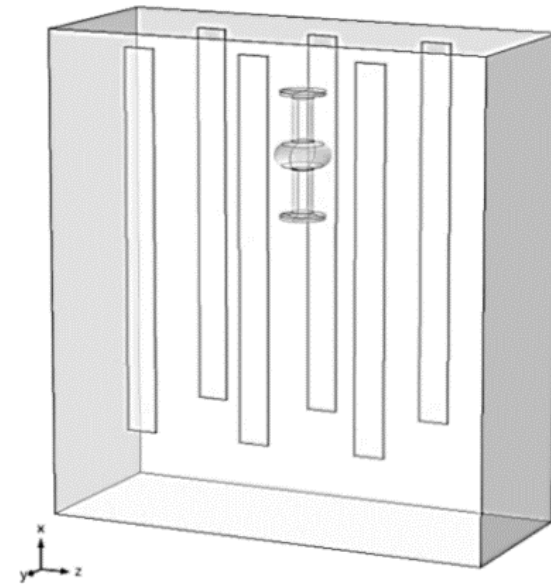
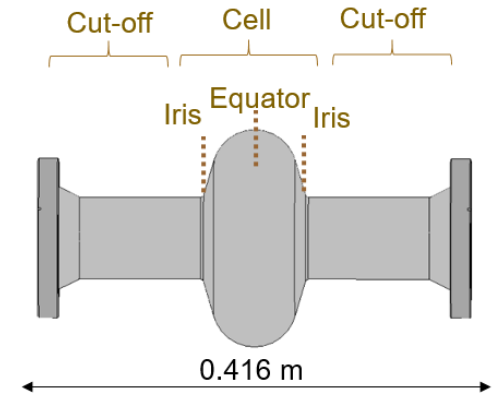
- The bottleneck of the process is the heterogeneous distribution of the plated copper layer along the cavity and the resulting thinner section at the cavity iris.



COMSOL® simulations are performed to optimise the copper thickness uniformity along the cavity.

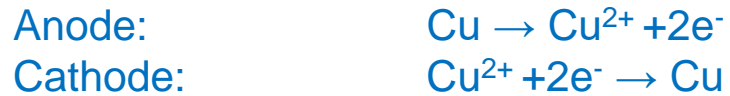
## Secondary Current Distribution (SCD) physics module.

- Voltage
- Local current density
- Deposited thickness



# Computational methods

The electron transfer reactions that take place are:



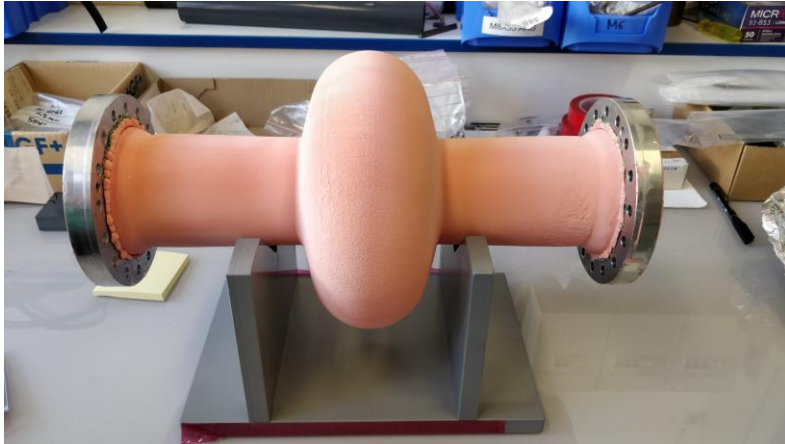
Local current density and the local potential derivative are described by the Ohm's law.

The local current at the electrode surface follows the Butler-Volmer equation:

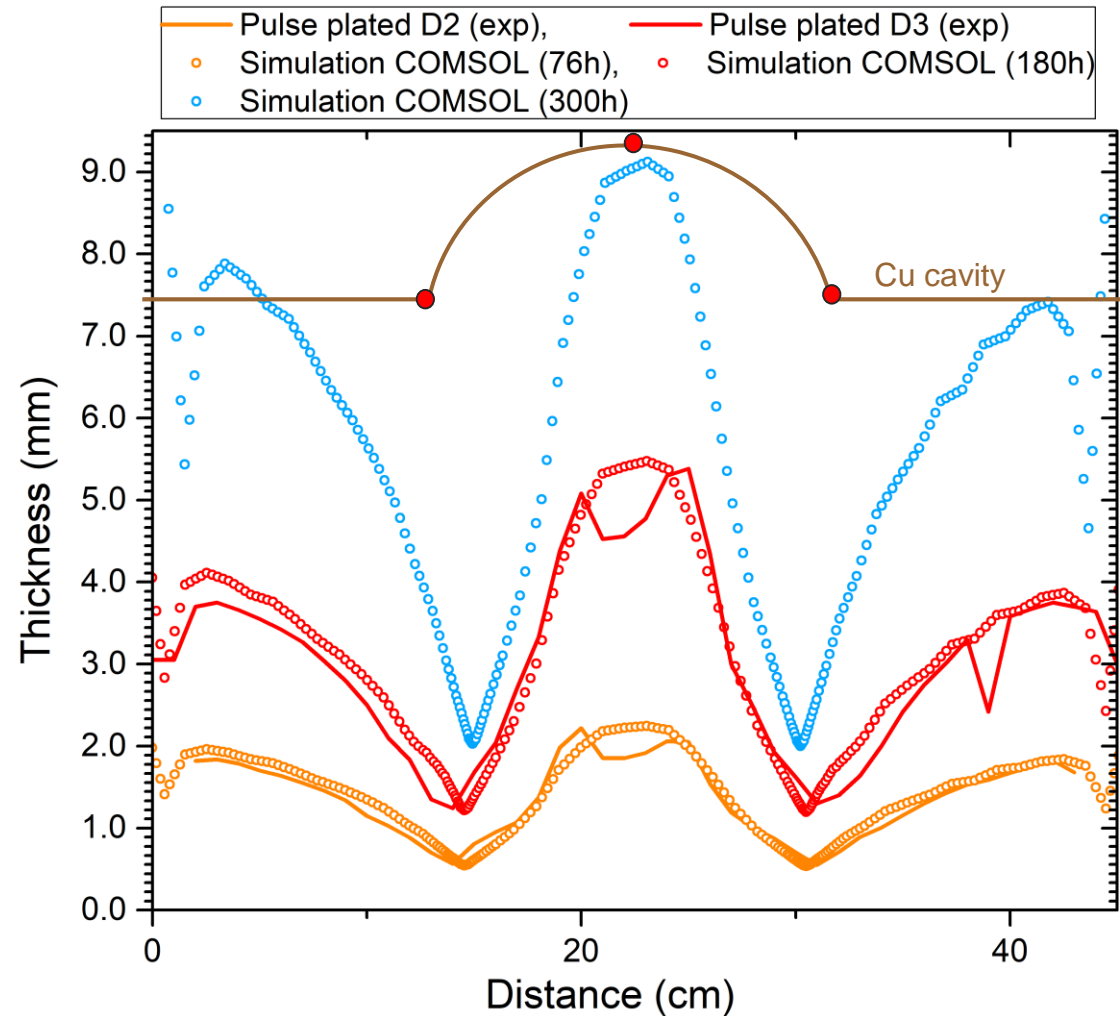
$$i_{loc,Cu} = i_{0,Cu} \left( \exp\left(\frac{\alpha_a \cdot F \cdot \eta_{Cu}}{R \cdot T}\right) - \exp\left(\frac{-\alpha_c \cdot F \cdot \eta_{Cu}}{R \cdot T}\right) \right)$$

The simulations were run with a moving mesh in order to simulate the boundary displacement resulting from the plating on the cathode and the consumption of the secondary anodes.

# Validation of simulation model

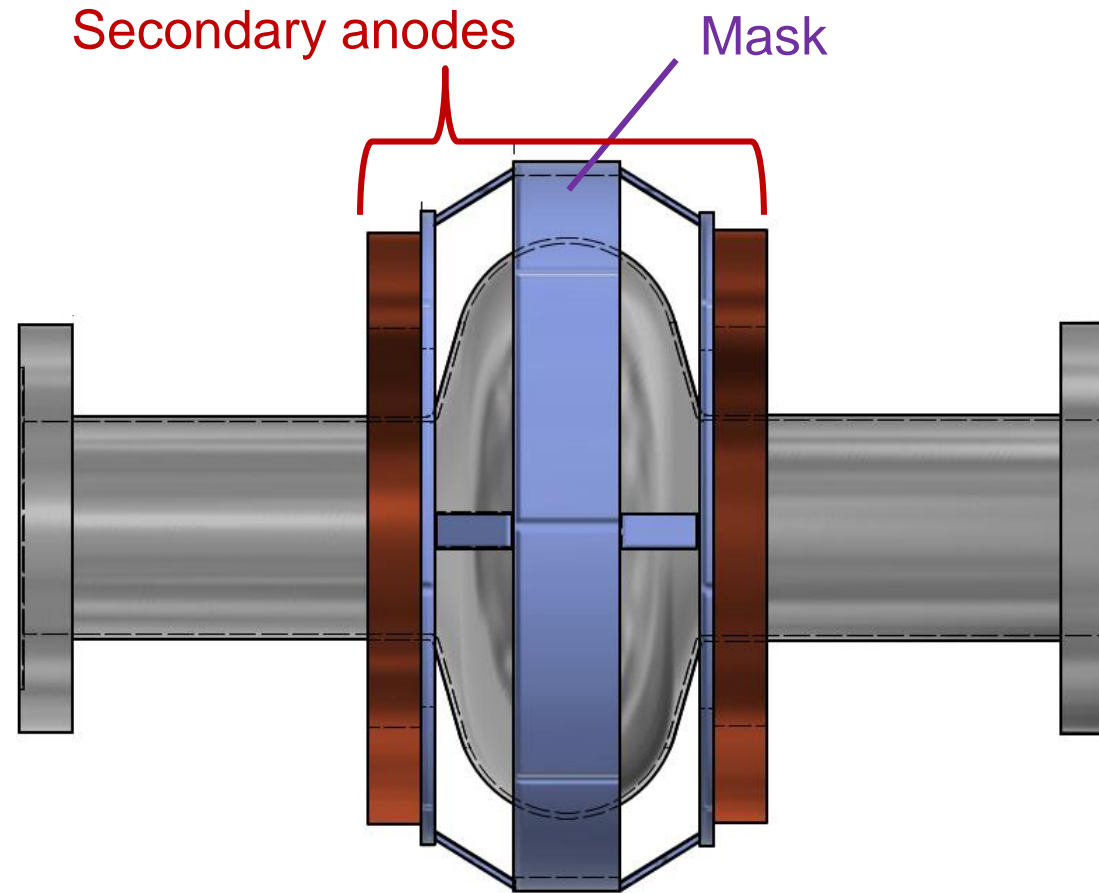


- The simulated thickness agrees with the experimental values.
- The maximum thickness is located at equator, the minimum at the iris.
- 300 hours to achieve a thickness of 2 mm at the iris.

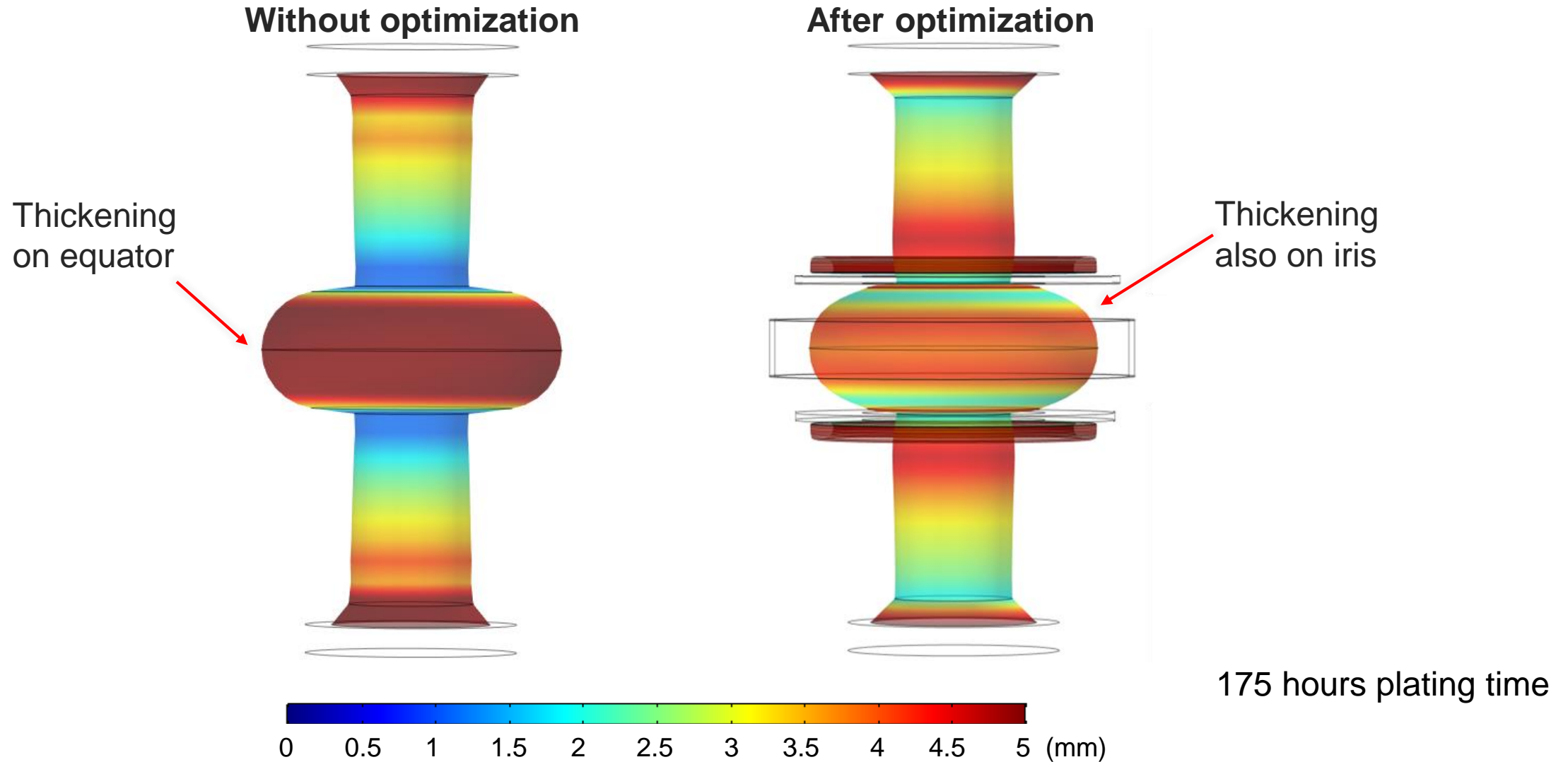


# Design of secondary anodes and masking

- Solution for uniformity: Secondary anodes positioned at the iris to promote plating, mask at the equator to reduce the deposition.



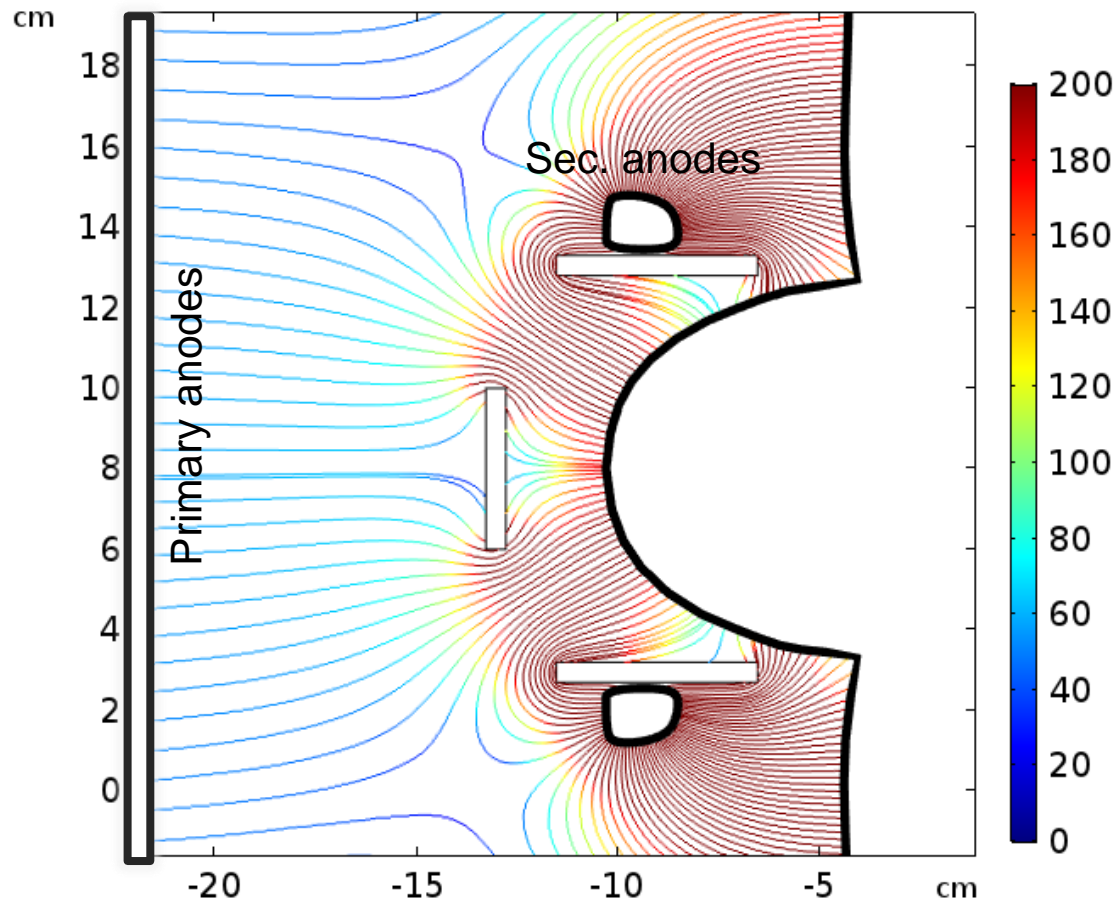
# Design of secondary anodes and masking





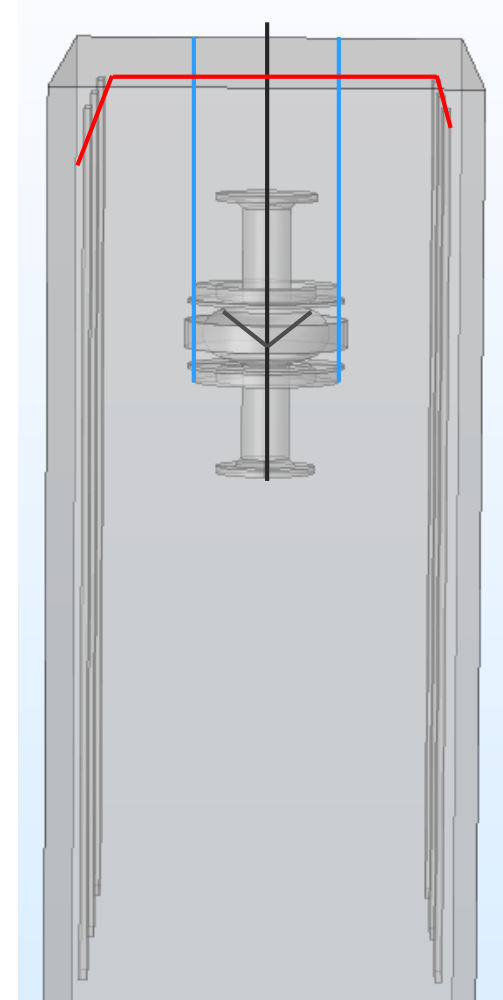
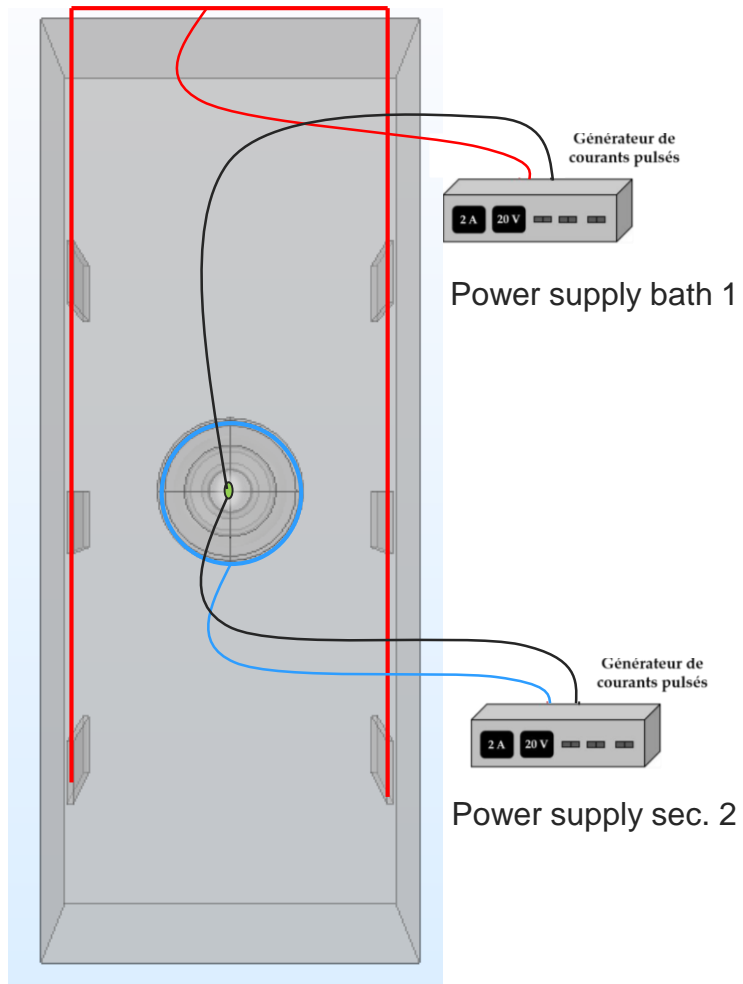
# Optimisation of anodic dissolution

Electrolyte current density

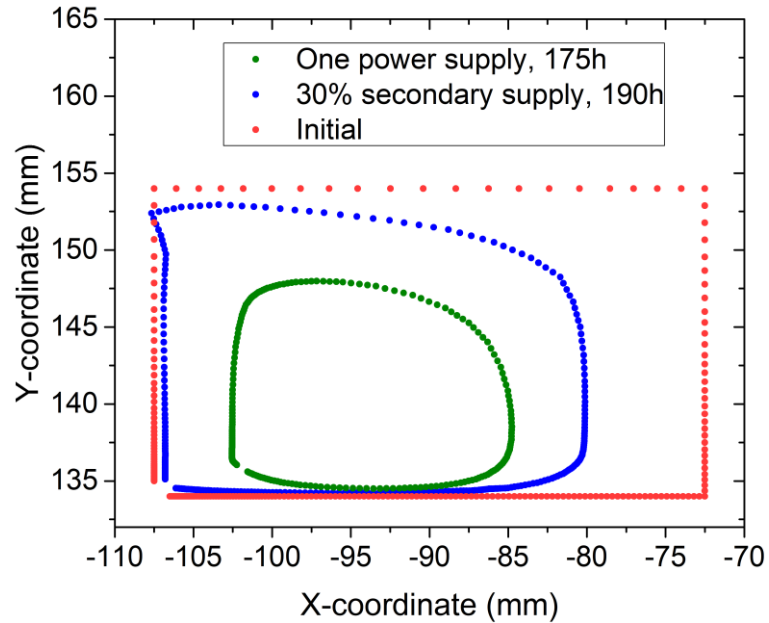
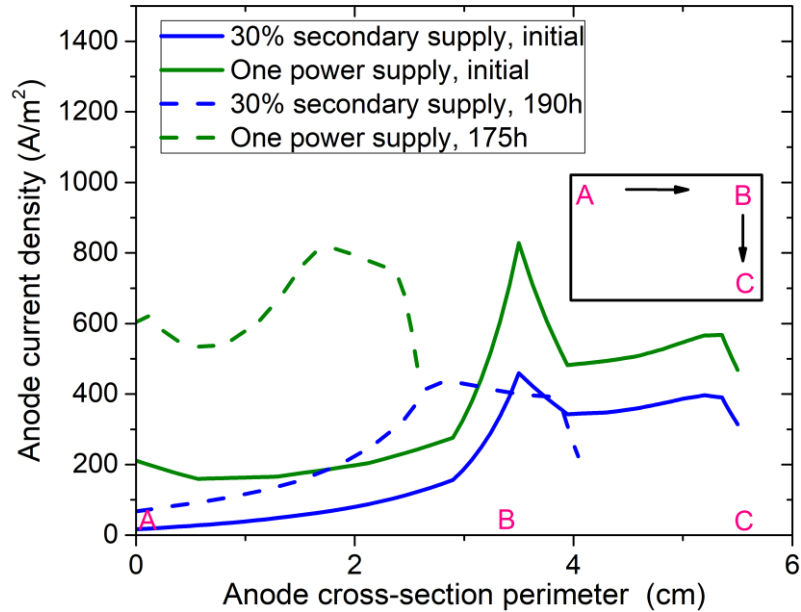


- Current line distribution with both anodes at same voltage (1PS).
- 175 hours plating time

# Optimisation of anodic dissolution

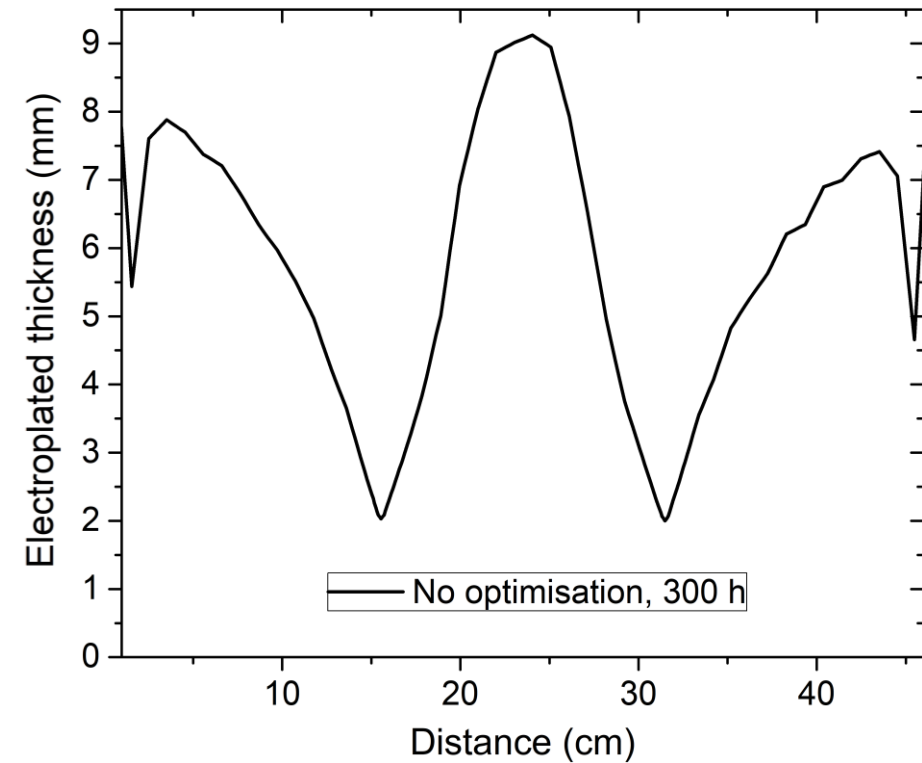
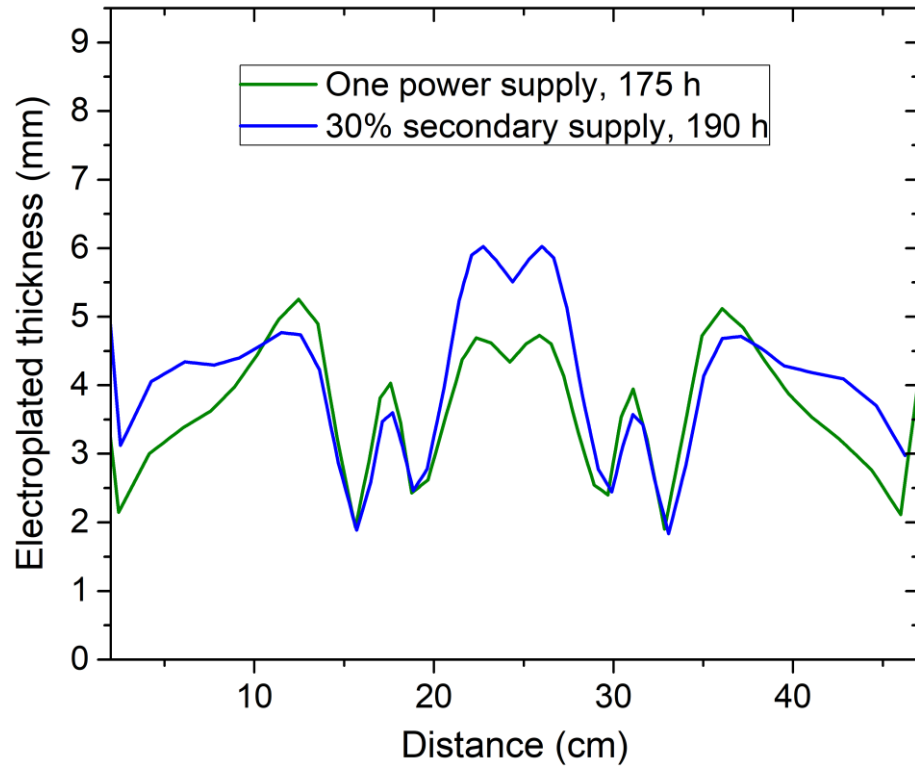


# Optimisation of anodic dissolution



- Severe anodic dissolution and high current density at the sec. anodes with one power supply and both anodes at same voltage.
- Split of 30% of total current on secondary supply on sec. anodes minimize anode consumption and improves control over the process.

# Optimisation of anodic dissolution



- To achieve a thickness of 2 mm at the iris, time increased to 190 hours.

# Conclusions

- COMSOL modelisation of the electroforming process:
  - ❖ Define an optimised geometry of anode and masking that highly improves the copper layer thickness distribution.
- The re-meshing of the anodes:
  - ❖ Identify the anode end-life and determine the secondary anode current density.
- Two power supplies were implemented to control independently the primary and secondary anodes.
  - ❖ The current density at the sec. anodes was reduced.
    - Minimize anode consumption.
    - Overall control of the process was improved.

